

# GA75TS60U

"HALF-BRIDGE" IGBT INT-A-PAK

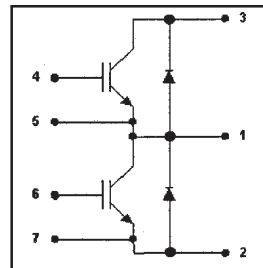
Ultra-Fast™ Speed IGBT

## Features

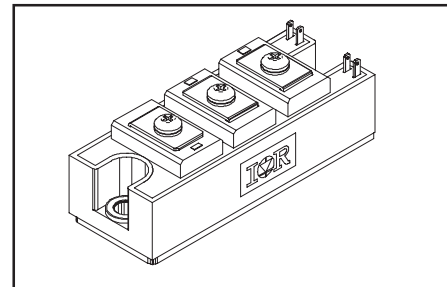
- Generation 4 IGBT technology
- UltraFast: Optimized for high operating frequencies 8-40 kHz in hard switching, >200 kHz in resonant mode
- Very low conduction and switching losses
- HEXFRED™ antiparallel diodes with ultra- soft recovery
- Industry standard package
- UL approved

## Benefits

- Increased operating efficiency
- Direct mounting to heatsink
- Performance optimized for power conversion: UPS, SMPS, Welding
- Lower EMI, requires less snubbing



|                                  |
|----------------------------------|
| $V_{CES} = 600V$                 |
| $V_{CE(on)} \text{ typ.} = 1.7V$ |
| @ $V_{GE} = 15V, I_C = 75A$      |



## Absolute Maximum Ratings

|                          | Parameter                                                        | Max.        | Units      |
|--------------------------|------------------------------------------------------------------|-------------|------------|
| $V_{CES}$                | Collector-to-Emitter Voltage                                     | 600         | V          |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current                                     | 75          | A          |
| $I_{CM}$                 | Pulsed Collector Current*                                        | 150         |            |
| $I_{LM}$                 | Peak Switching Current,                                          | 150         |            |
| $I_{FM}$                 | Peak Diode Forward Current                                       | 150         |            |
| $V_{GE}$                 | Gate-to-Emitter Voltage                                          | $\pm 20$    | V          |
| $V_{ISOL}$               | RMS Isolation Voltage, Any Terminal To Case, $t = 1 \text{ min}$ | 2500        | W          |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation                                        | 285         |            |
| $P_D @ T_C = 85^\circ C$ | Maximum Power Dissipation                                        | 150         | $^\circ C$ |
| $T_J$                    | Operating Junction Temperature Range                             | -40 to +150 |            |
| $T_{STG}$                | Storage Temperature Range                                        | -40 to +125 |            |

## Thermal / Mechanical Characteristics

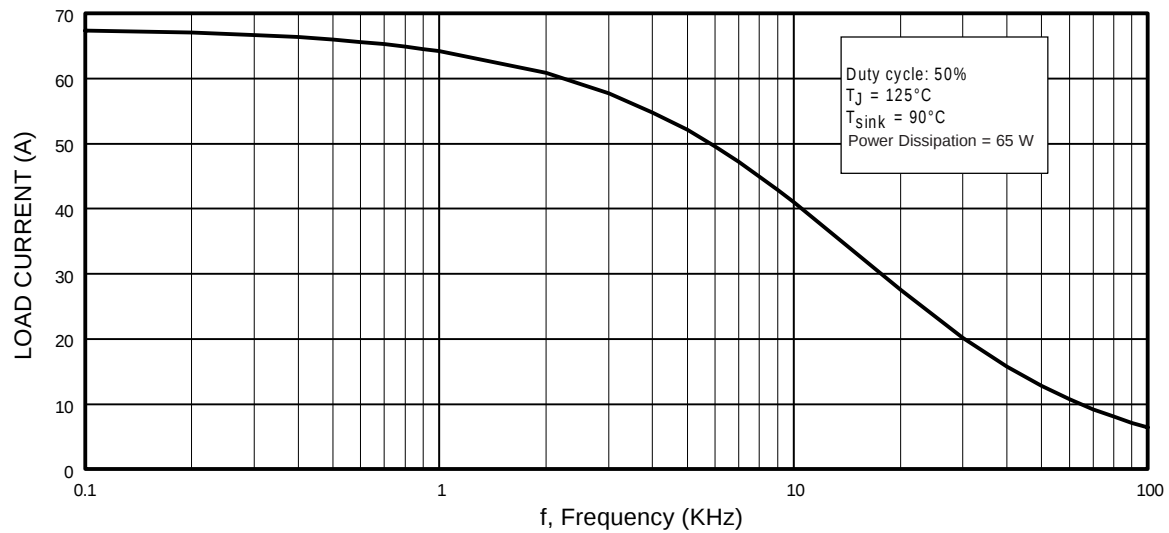
|                 | Parameter                                    | Typ. | Max. | Units        |
|-----------------|----------------------------------------------|------|------|--------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case - IGBT  | —    | 0.44 | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case - Diode | —    | 0.70 |              |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink - Module    | 0.1  | —    |              |
|                 | Mounting Torque, Case-to-Heatsink            | —    | 4.0  | N·m          |
|                 | Mounting Torque, Case-to-Terminal 1, 2 & 3f  | —    | 3.0  |              |
|                 | Weight of Module                             | 200  | —    | g            |

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

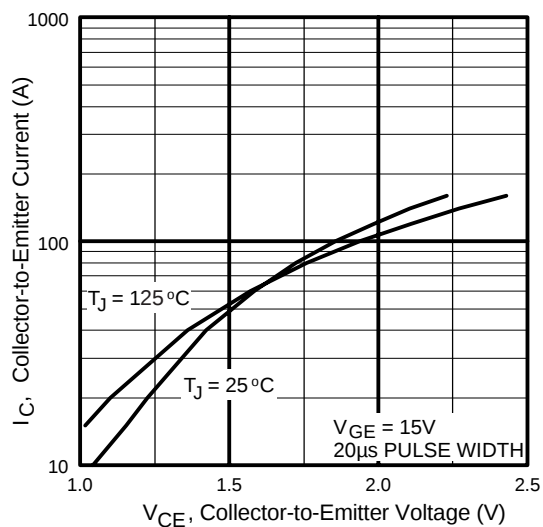
|                                | Parameter                               | Min. | Typ. | Max. | Units                | Conditions                                            |
|--------------------------------|-----------------------------------------|------|------|------|----------------------|-------------------------------------------------------|
| $V_{(BR)CES}$                  | Collector-to-Emitter Breakdown Voltage  | 600  | —    | —    | V                    | $V_{GE} = 0V, I_C = 1mA$                              |
| $V_{CE(on)}$                   | Collector-to-Emitter Voltage            | —    | 1.7  | 2.2  |                      | $V_{GE} = 15V, I_C = 75A$                             |
|                                |                                         | —    | 1.76 | —    |                      | $V_{GE} = 15V, I_C = 75A, T_J = 125^\circ\text{C}$    |
| $V_{GE(th)}$                   | Gate Threshold Voltage                  | 3.0  | —    | 6.0  |                      | $I_C = 0.5mA$                                         |
| $\Delta V_{GE(th)}/\Delta T_J$ | Temperature Coeff. of Threshold Voltage | —    | -11  | —    | mV/ $^\circ\text{C}$ | $V_{CE} = V_{GE}, I_C = 500\mu A$                     |
| $g_{fe}$                       | Forward Transconductance „              | —    | 83   | —    | S                    | $V_{CE} = 25V, I_C = 75A$                             |
| $I_{CES}$                      | Collector-to-Emitter Leaking Current    | —    | —    | 1.0  | mA                   | $V_{GE} = 0V, V_{CE} = 600V$                          |
|                                |                                         | —    | —    | 10   |                      | $V_{GE} = 0V, V_{CE} = 600V, T_J = 125^\circ\text{C}$ |
| $V_{FM}$                       | Diode Forward Voltage - Maximum         | —    | 3.3  | —    | V                    | $I_F = 75A, V_{GE} = 0V$                              |
|                                |                                         | —    | 3.1  | —    |                      | $I_F = 75A, V_{GE} = 0V, T_J = 125^\circ\text{C}$     |
| $I_{GES}$                      | Gate-to-Emitter Leakage Current         | —    | —    | 250  | nA                   | $V_{GE} = \pm 20V$                                    |

**Dynamic Characteristics -  $T_J = 125^\circ\text{C}$  (unless otherwise specified)**

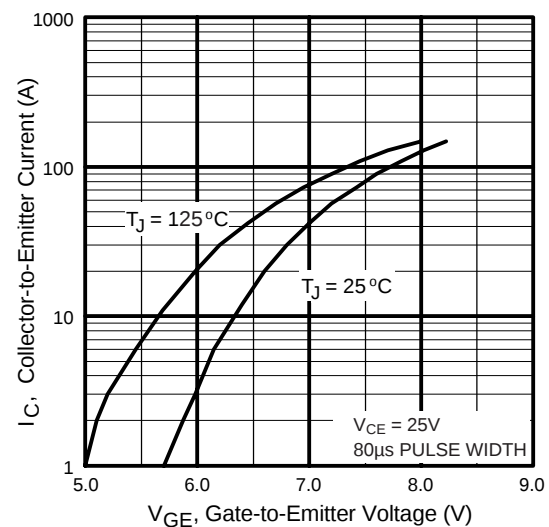
|                  | Parameter                                        | Min. | Typ. | Max. | Units      | Conditions                               |
|------------------|--------------------------------------------------|------|------|------|------------|------------------------------------------|
| $Q_g$            | Total Gate Charge (turn-on)                      | —    | 340  | 510  | nC         | $V_{CC} = 400V, V_{GE} = 15V$            |
| $Q_{ge}$         | Gate - Emitter Charge (turn-on)                  | —    | 48   | 72   |            | $I_C = 75A$                              |
| $Q_{gc}$         | Gate - Collector Charge (turn-on)                | —    | 120  | 170  |            | $T_J = 25^\circ\text{C}$                 |
| $t_{d(on)}$      | Turn-On Delay Time                               | —    | 110  | —    | ns         | $R_{G1} = 27\Omega, R_{G2} = 0\Omega,$   |
| $t_r$            | Rise Time                                        | —    | 94   | —    |            | $I_C = 75A$                              |
| $t_{d(off)}$     | Turn-Off Delay Time                              | —    | 250  | —    |            | $V_{CC} = 360V$                          |
| $t_f$            | Fall Time                                        | —    | 180  | —    |            | $V_{GE} = \pm 15V$                       |
| $E_{on}$         | Turn-On Switching Energy                         | —    | 1.95 | —    | mJ         |                                          |
| $E_{off(1)}$     | Turn-Off Switching Energy                        | —    | 4.4  | —    |            |                                          |
| $E_{ts(1)}$      | Total Switching Energy                           | —    | 6.35 | 12.6 |            |                                          |
| $C_{ies}$        | Input Capacitance                                | —    | 7880 | —    | pF         | $V_{GE} = 0V$                            |
| $C_{oes}$        | Output Capacitance                               | —    | 770  | —    |            | $V_{CC} = 30V$                           |
| $C_{res}$        | Reverse Transfer Capacitance                     | —    | 98   | —    |            | $f = 1\text{ MHz}$                       |
| $t_{rr}$         | Diode Reverse Recovery Time                      | —    | 133  | —    | ns         | $I_C = 75A$                              |
| $I_{rr}$         | Diode Peak Reverse Current                       | —    | 94   | —    | A          | $R_{G1} = 27\Omega$                      |
| $Q_{rr}$         | Diode Recovery Charge                            | —    | 6274 | —    | nC         | $R_{G2} = 0\Omega$                       |
| $di_{(rec)M}/dt$ | Diode Peak Rate of Fall of Recovery During $t_b$ | —    | 2061 | —    | A/ $\mu s$ | $V_{CC} = 360V$<br>$di/dt = 1300A/\mu s$ |



**Fig. 1** - Typical Load Current vs. Frequency  
(Load Current =  $I_{\text{RMS}}$  of fundamental)



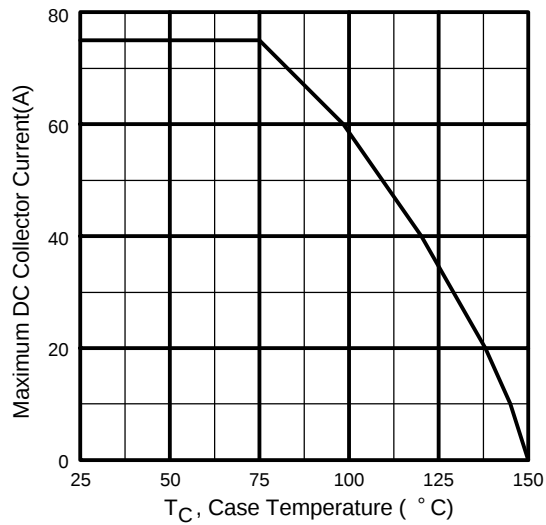
**Fig. 2** - Typical Output Characteristics



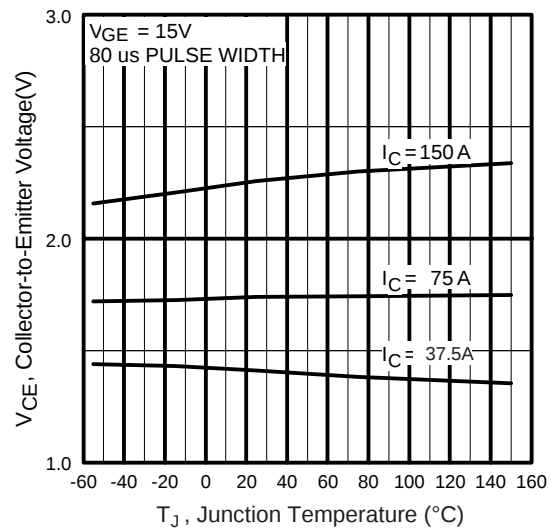
**Fig. 3** - Typical Transfer Characteristics

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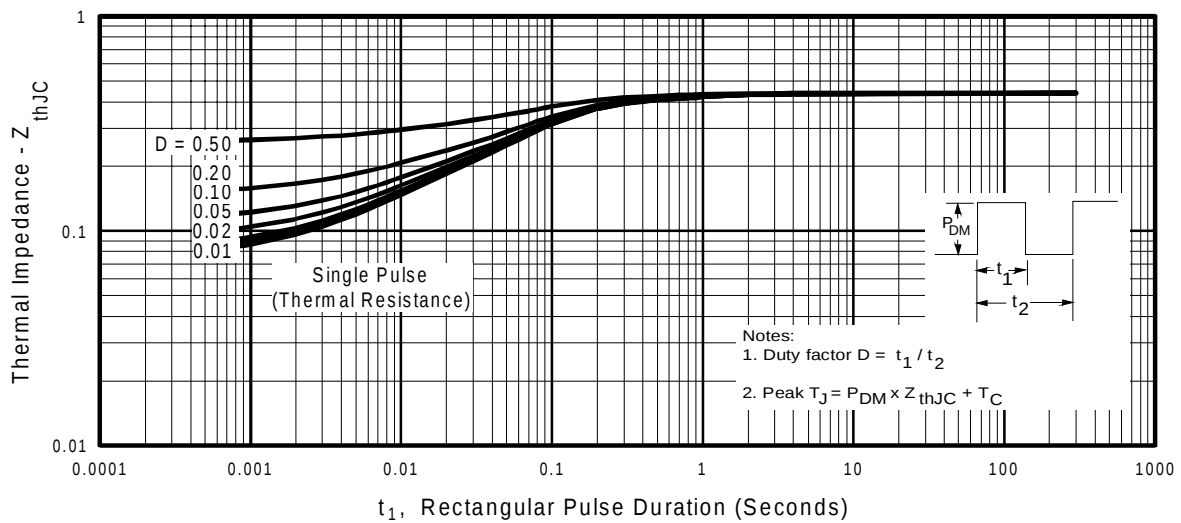
International  
**IR** Rectifier



**Fig. 4** - Maximum Collector Current vs. Case Temperature

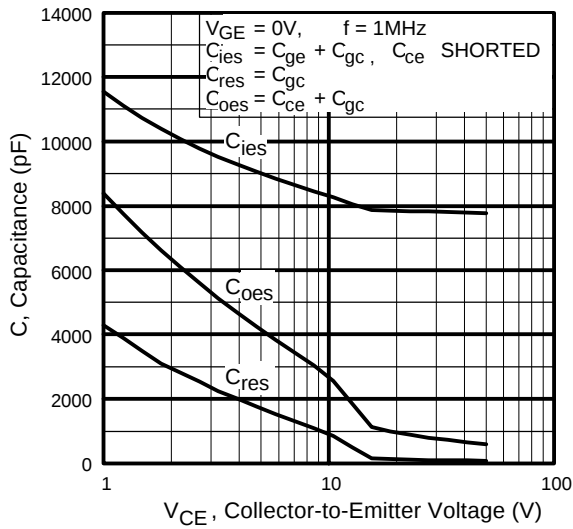


**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature

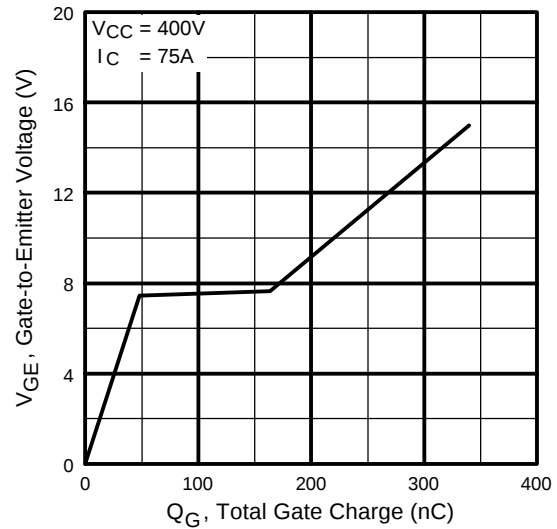


**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case

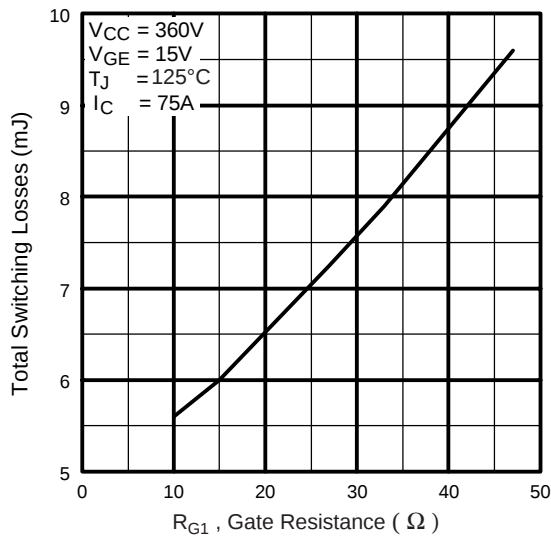
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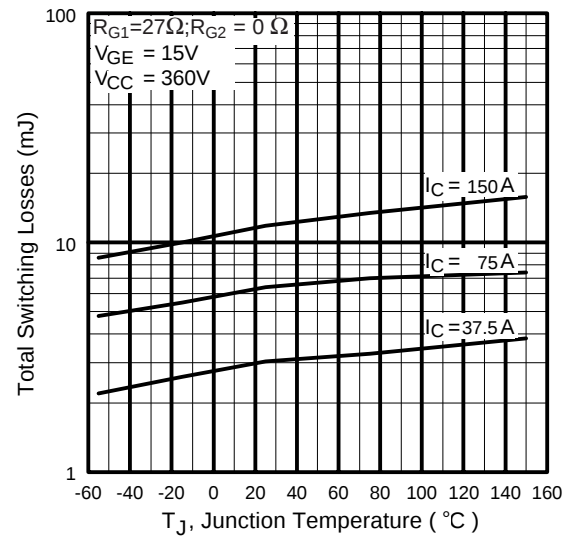
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



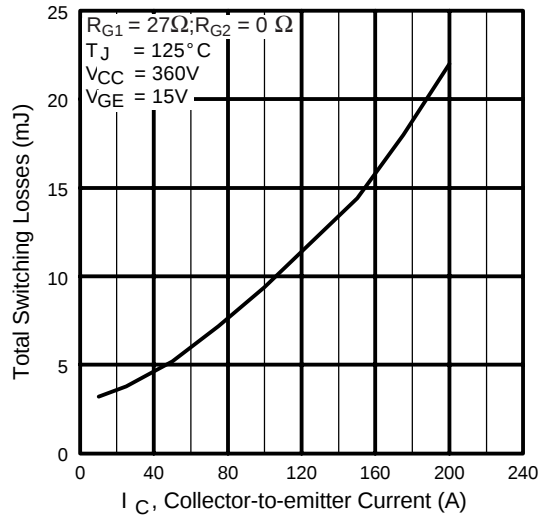
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



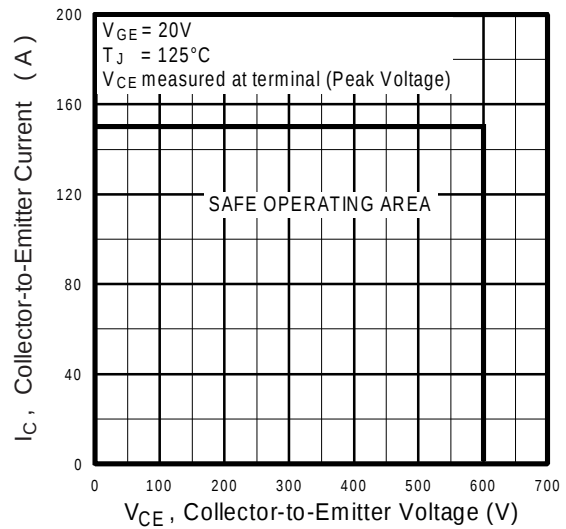
**Fig. 10** - Typical Switching Losses vs. Junction Temperature

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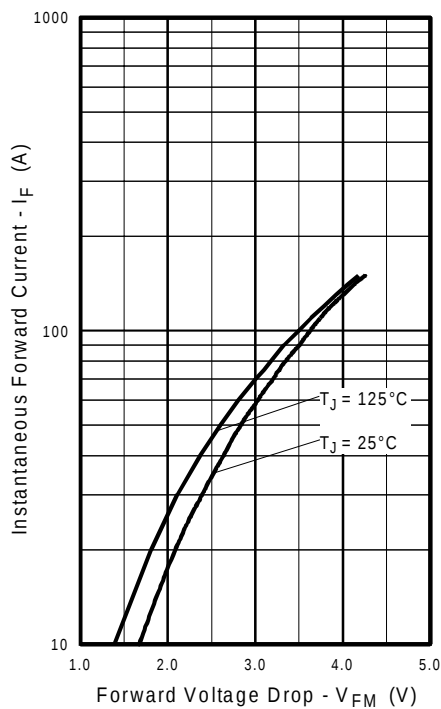
International  
**IR** Rectifier



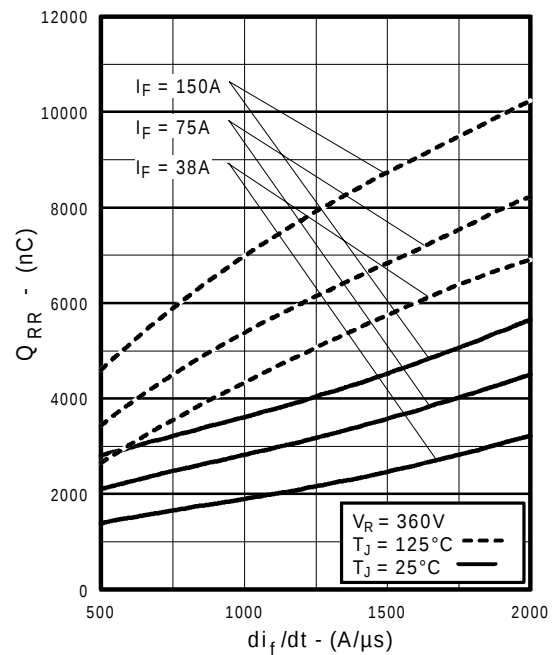
**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



**Fig. 12** - Reverse Bias SOA

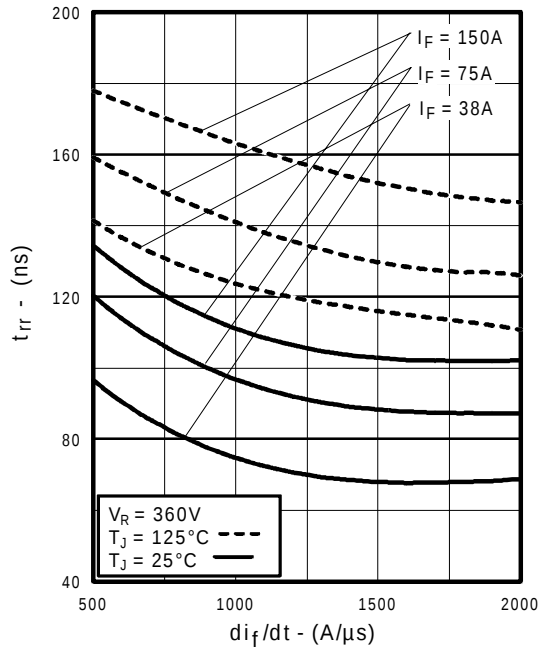


**Fig. 13** - Typical Forward Voltage Drop vs. Instantaneous Forward Current

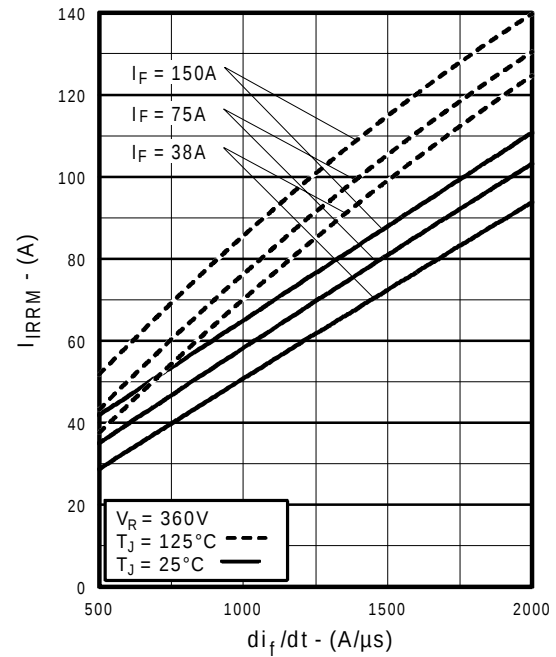


**Fig. 14** - Typical Stored Charge vs.  $di_f/dt$

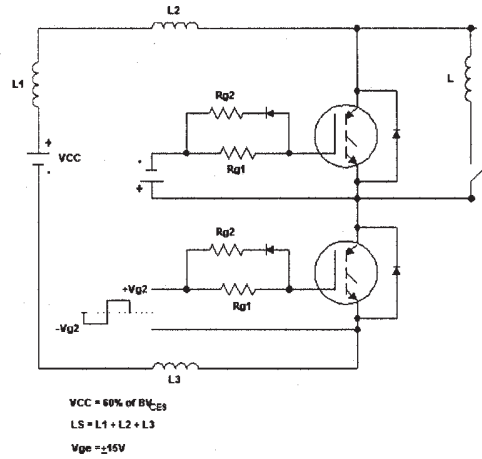
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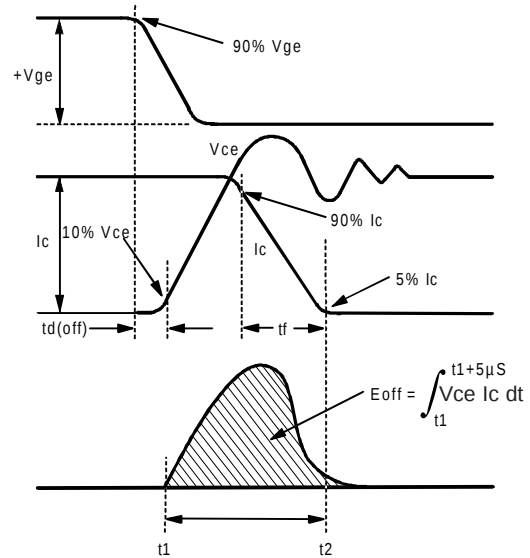
**Fig. 15** - Typical Reverse Recovery vs.  $di_f/dt$



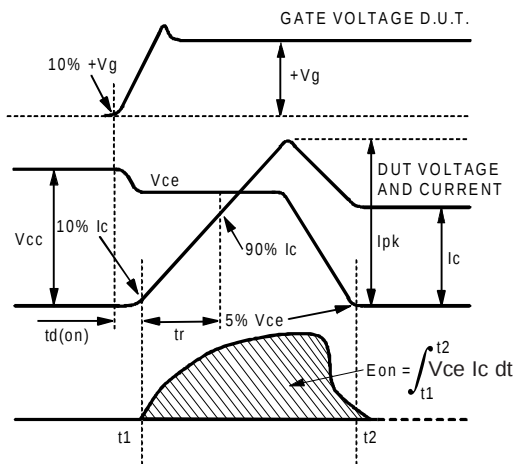
**Fig. 16** - Typical Recovery Current vs.  $di_f/dt$



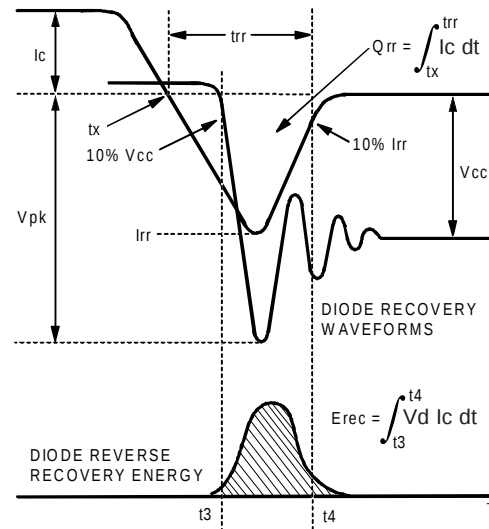
**Fig. 17** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18** - Test Waveforms for Circuit of Fig. 17, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 19** - Test Waveforms for Circuit of Fig. 17, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 20** - Test Waveforms for Circuit of Fig. 17, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$

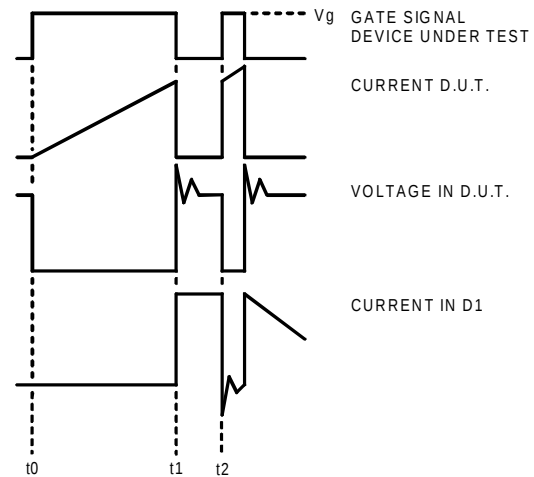


Figure 21. Macro Waveforms for Figure 17's Test Circuit

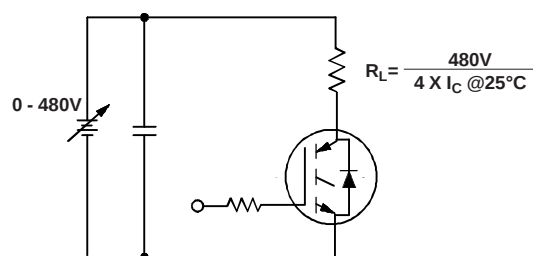
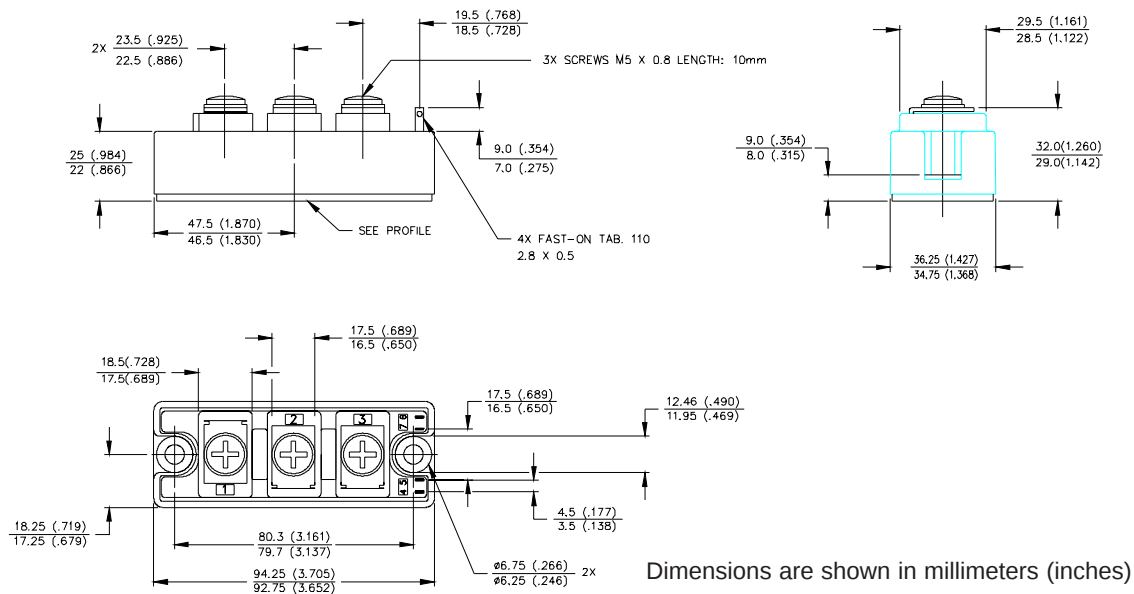


Figure 22. Pulsed Collector Current  
Test Circuit

International  
**IOR** Rectifier

- ① Repetitive rating;  $V_{GE} = 20V$ , pulse width limited by max. junction temperature.
- ② See fig. 17
- ③ For screws M5x0.8
- ④ Pulse width 80 $\mu$ s; single shot.

## Case Outline — INT-A-PAK



Dimensions are shown in millimeters (inches)

# International IOR Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

**EUROPEAN HEADQUARTERS:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

<http://www.irf.com/>

*Data and specifications subject to change without notice.*

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